

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10825253	KIM ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Mui, Christine T	1709

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
435	14	27 August 2007	CTM
600	322, 300	10 September 2007	CTM
205	777.5	27 August 2007	CTM
422	68.1	27 August 2007	CTM
128	633	27 August 2007	CTM
204	195 R, 403, 403.04	10 September 2007	CTM
702	19	10 September 2007	CTM
204	403.01	29 May 2008	CTM

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
See EAST Search	27 August 2007	CTM
See STN Search Report	10 September 2007	CTM
See Updated EAST Search Report	29 May 2008	CTM
See Updated EAST Search Report	23 December 2008	CTM

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>